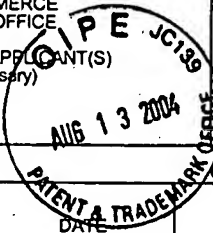
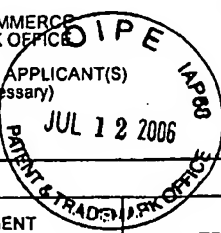



FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 00862.023164.		APPLICATION NO. 10/629,709	
			APPLICANT HITOSHI WATANABE			
			FILING DATE July 30, 2003		GROUP 2622	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/TP/	5,369,746	11/29/94	Takashi Nakamura, et al.	395	200	
/TP/	5,579,495	11/26/96	Kunitaka Ozawa, et al.	395	383	
/TP/	5,887,173	03/23/99	Yasuyuki Ogawa, et al.	395	704	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	/Thierry Pham/			DATE CONSIDERED		
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				APPLICANT HITOSHI WATANABE			
				FILING DATE July 30, 2003		ART UNIT 2625	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/TP/		6,717,689	04/06/04	Endo et al.	358	1.15	
/TP/		5,832,298	11/03/98	Sanchez et al.	710	8	
/TP/		2002/0093682 A1	07/18/02	Nakajima	358	1.16	
/TP/		2001/0022624 A1	09/20/01	Tanaka et al.	348	333.02	
/TP/		2006/0087568 A1	04/27/06	Tanaka et al.	348	231.99	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/TP/	JPA	2000-137593	05/16/00	Japan	G06F	3/12	Abstract; corresponds to USP6,717,689
/TP/	JPA	11-085422	03/30/99	Japan	G06F	3/12	Abstract
/TP/	JPA	09-026867	01/28/97	Japan	G06F	3/14	Abstract; Corresponds to USP5,832,298
/TP/	JPA	2002-211082	07/31/02	Japan	B41J	29/38	Abstract; Corresponds to US Pub. 2002/093682 A1
/TP/	JPA	2001-268485	09/28/01	Japan	H04N	5/76	Abstract; Corresponds to US Pubs. 2001/0022624A1 and 2006/0087568 A1
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